



Subject card

Subject name and code	Measuring and measurement systems, PG_00071279						
Field of study	Technologies for Industry 5.0						
Date of commencement of studies	October 2026	Academic year of realisation of subject				2026/2027	
Education level	first-cycle studies	Subject group				Obligatory subject group in the field of study	
Mode of study	Full-time studies	Mode of delivery				at the university	
Year of study	1	Language of instruction				Polish	
Semester of study	2	ECTS credits				6.0	
Learning profile	general academic profile	Assessment form				exam	
Conducting unit	Division of Magnetic Properties of Materials -> Institute of Nanotechnology and Materials Engineering -> Faculty of Applied Physics and Mathematics -> Faculties of Gdańsk University of Technology						
Name and surname of lecturer (lecturers)	Subject supervisor	dr inż. Marek Chmielewski					
	Teachers						
Lesson types	Lesson type	Lecture	Tutorial	Laboratory	Project	Seminar	SUM
	Number of study hours	30.0	0.0	45.0	0.0	0.0	75
	E-learning hours included: 0.0						
Learning activity and number of study hours	Learning activity	Participation in didactic classes included in study plan		Participation in consultation hours		Self-study	SUM
	Number of study hours	75		5.0		70.0	150
Subject objectives	The purpose of the course is, first of all, to familiarize the student with the operation of basic power and control-measurement tools, based on modern digital technology, used in electronic laboratory practice as well as in non-laboratory conditions, to familiarize students with the technique of digital data processing and the determination of measurement uncertainty. The next objective will be the task of using control and measurement tools in the field of independent electronic prototyping. The student will get acquainted with the meaning and importance of constructing conditioning modules, understand the basic laws that apply in electronic metrology.						
Learning outcomes	Course outcome		Subject outcome			Method of verification	
	[K6_U05] interprets phenomena occurring around the technological process and processes occurring in the life cycle of devices and systems, makes a critical assessment of the functioning of existing solutions		The student will learn digital data processing techniques, gain the ability to critically analyze the obtained measurement results, be able to analyze the correctness of complex measurement processes, gain the ability to optimize in the field of metrology of measurement systems.			[SU4] Assessment of ability to use methods and tools [SU1] Assessment of task fulfilment	
	[K6_W05] demonstrates practical knowledge related to technological processes, utilized devices and systems, has knowledge regarding selected processes monitoring tools		The student will learn the capabilities of digital metrology used in modern measurement techniques. He or she will gain a working knowledge of the preparation of the elements and procedures necessary to carry out the measurement process, and will understand the importance of physical limitations in metrological processes.			[SW3] Assessment of knowledge contained in written work and projects	

Subject contents	<p>Course content – lecture The content of the course is, first, to acquire the student's ability to operate and use the following laboratory equipment: multi-section laboratory power supplies, digital universal multimeters, multi-channel digital oscilloscopes, function and arbitrary generators. In the second place, the student will obtain practical knowledge of the construction of electronic, simple prototype circuits using contact board-based techniques and PCB prototype boards, practice the process of planning an experiment, selecting the right measurement equipment, producing appropriate, content-compatible studies from the realized measurement experiment.</p> <p>Course content – laboratory During the laboratories, basic activities in the field of practical metrology will be carried out using various types of universal meters, simple digital oscilloscopes, arbitrary generators, and laboratory power supplies. For the purposes of measuring frequency characteristics, students will construct elementary electronic circuits on prototype boards. During the exercises, voltage divider circuits, integrating circuits, and differentiating circuits will be tested. Software control of measurement processes will also be covered.</p>											
Prerequisites and co-requisites	Not Required											
Assessment methods and criteria	<table border="1" data-bbox="451 465 1487 566"> <thead> <tr> <th data-bbox="451 465 794 495">Subject passing criteria</th> <th data-bbox="794 465 1137 495">Passing threshold</th> <th data-bbox="1137 465 1487 495">Percentage of the final grade</th> </tr> </thead> <tbody> <tr> <td data-bbox="451 495 794 524">Lab</td> <td data-bbox="794 495 1137 524">80.0%</td> <td data-bbox="1137 495 1487 524">70.0%</td> </tr> <tr> <td data-bbox="451 524 794 566">lecture</td> <td data-bbox="794 524 1137 566">50.0%</td> <td data-bbox="1137 524 1487 566">30.0%</td> </tr> </tbody> </table>			Subject passing criteria	Passing threshold	Percentage of the final grade	Lab	80.0%	70.0%	lecture	50.0%	30.0%
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Example issues/ example questions/ tasks being completed	<p>Analog-to-digital processing</p> <p>Digital universal meters</p> <p>Frequency analysis and electrical interference.</p>											
Practical activities within the subject	Not applicable											

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